



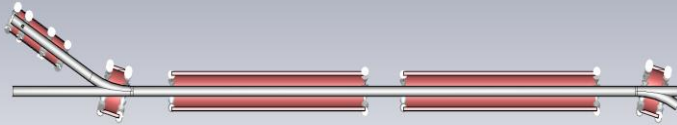
Beam dynamics simulations in electron lens test stand

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in collaboration with G. Stancari, FNAL



*8th HL-LHC Collaboration Meeting
CERN, October 17, 2018*

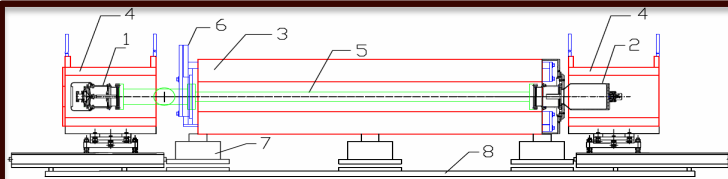
Outline



HEL @ HL-LHC

Simulations:

- Benchmarking
- Image analysis



E-lens test stand at FNAL



E-lens test stand at CERN

Existing electron lenses and HEL@HL-LHC

Tevatron, FERMILAB

Table 1: Electron Lens and Tevatron collider parameters.

Parameter	Symbol	Value	Unit
<i>Tevatron Electron Lens</i>			
Electron energy (oper./max)	U_e	5/10	kV
Peak electron current (oper./max)	J_e	0.6/3	A
Magnetic field in main/gun solenoid	B_{main}	30	kG
Radius: cathode/e-beam in main solenoid	a_c	7.5	mm
e-pulse period/width, $\sigma_{to, \sigma}$	T_p	21	μ s
	T_r	≈ 0.6	
Interaction length	L_e	2.0	m
<i>Tevatron Collider Parameters</i>			
Circumference	C	6.28	km
Proton/antiproton beam energy	E	980	GeV
Proton bunch intensity	N_p	250	10^9
Antiproton bunch intensity	N_a	50-100	10^9
Emittance proton, antiproton. (norm., rms)	ϵ_p	≈ 2.8	μ m
Number of bunches, bunch spacing	N_b	36	ns
Initial luminosity	L_0	1.5-2.9	10^{32} cm ⁻² s ⁻¹
Beta functions, TEL2	β_x/β_z	150/68	m
Beta functions, TEL1	β_x/β_z	29/104	m
Proton/antiproton head-on tunes/shift	ξ^p	≈ 0.008	max., per
	ξ^a	≈ 0.011	IP
Proton/antiproton long-range tunes/shift	ΔQ^p	≈ 0.003	max.
	ΔQ^a	≈ 0.006	

V. Kamerzhiev, Progress with Tevatron electron lenses, Proceedings of COOL 2007, Bad Kreuznach, Germany

RHIC, BNL

TABLE I. The parameters for the RHIC electron lenses.

Parameter	Unit	Value	Value
<i>Proton beam parameters</i>			
Total proton energy E_p	GeV	250	100
Relativistic factor γ_p		266.4	106.8
Bunch intensity N_p	10^{11}	3.0	2.25
$\beta^{*}_{x,y}$ at IP6, IP8 (p-p)	m	0.5	0.85
$\beta^{*}_{x,y}$ at IP10 (p-e)	m	10.0	15.0
Lattice tunes (Q_x, Q_y)		(0.695, 0.685)	(0.685, 0.685)
Phase advance (IP8-IP10)	Degree	180	180
rms emittance ϵ_n , initial	mm mrad	2.5	2.8
rms beam size at IP6, IP8, σ'_p	μ m	70	150
rms beam size at IP10, σ'_p	μ m	310	630
rms bunch length σ_c	m	0.50	0.70
Beam-beam parameter ξ /IP		0.0147	0.0097
Number of beam-beam IPs		2 + 1	2 + 1
<i>Electron lens parameters</i>			
Distance of center from IP	m	1.5	1.5
Effective length L_e	m	2.1	2.1
Kinetic energy E_e	kV	5	5
Relativistic factor β_e		0.14	0.14
Relativistic factor γ_e		1.0002	1.0002
Current I_e	A	1.0	0.43/0.64
Electron beam size at interaction	μ m	350	650
Linear tune shift		0.0147	0.01

X. Gu, Electron lenses for head-on beam-beam compensation in RHIC, Physical review accelerators and beams 20, 023501 (2017)

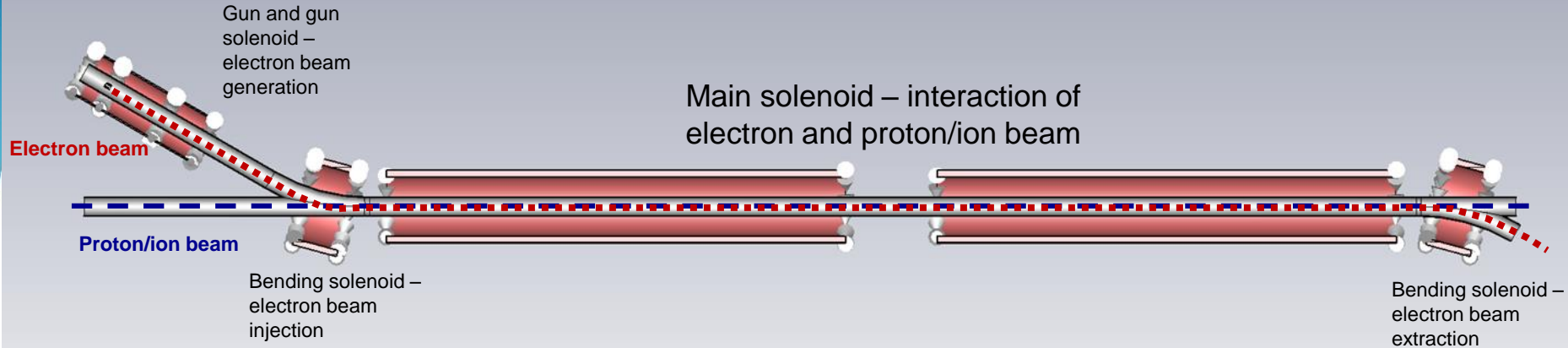
HL-LHC, CERN

Current 5A at 15kV
 Beam shape Hollow beam
 Effective length 2.9 m

HEL@HL-LHC has
 higher current,
 higher current density
 longer effective length
 comparing to implemented electron lenses

HEL components (gun, diagnostics, modulator, etc.) are unique.

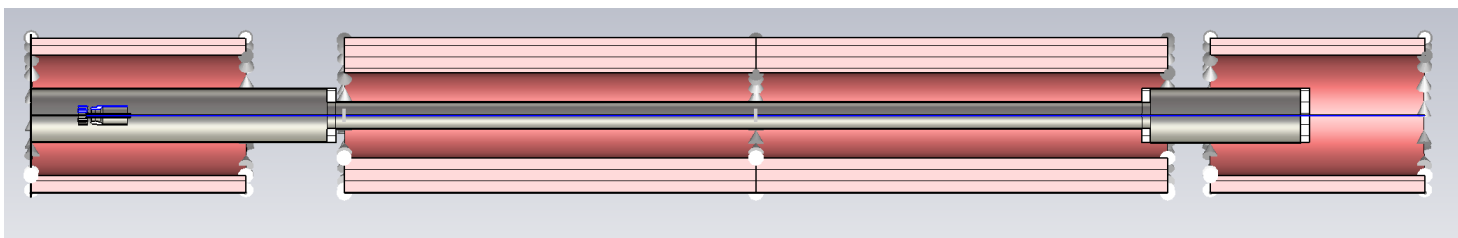
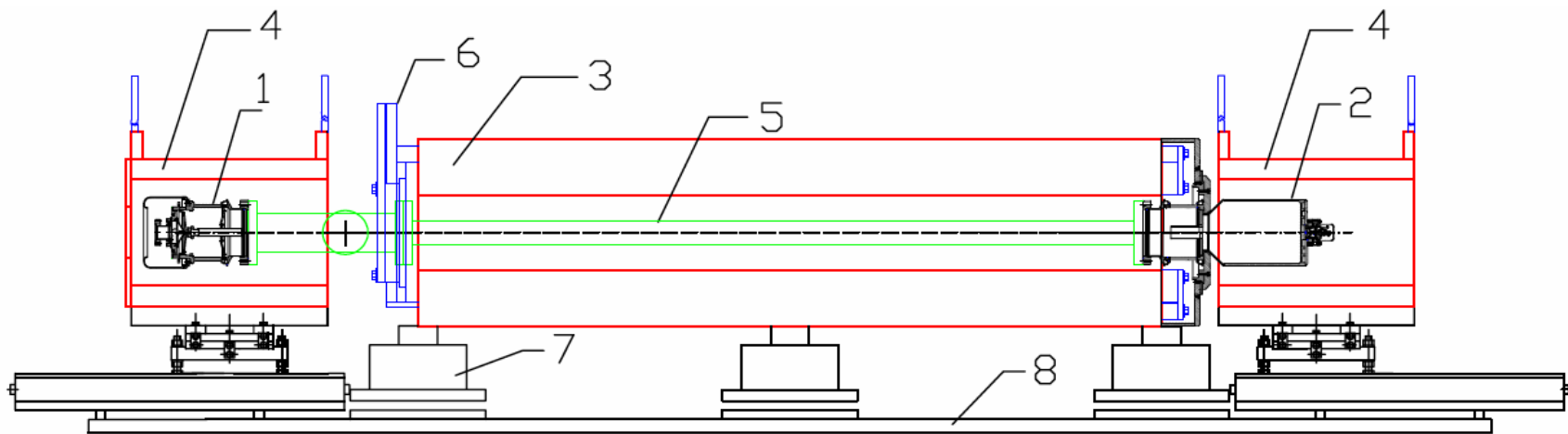
Beam dynamics in electron lens (short overview)



$$\frac{d\mathbf{r}_{\text{guiding centre}}}{dt} = v_{\parallel} \frac{\mathbf{B}}{|\mathbf{B}|} + \frac{\mathbf{E}_{\perp} \times \mathbf{B}}{B^2} + v_{\perp} \frac{\mathbf{B} \times \nabla \mathbf{B}}{B^2} - \frac{v_{\parallel}^2}{\omega_c} \frac{\mathbf{R}_c \times \mathbf{B}}{R^2 |\mathbf{B}|}$$

- In the presence of drift tube – possible formation of virtual cathode
- Intensity modulation – possible change of longitudinal profile
- Reliable simulation tool and test stand is required for development/ studying and optimization of the hollow electron lenses for HL-LHC.

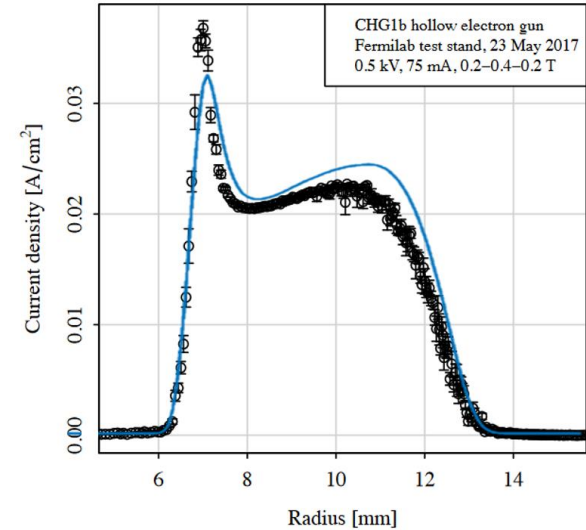
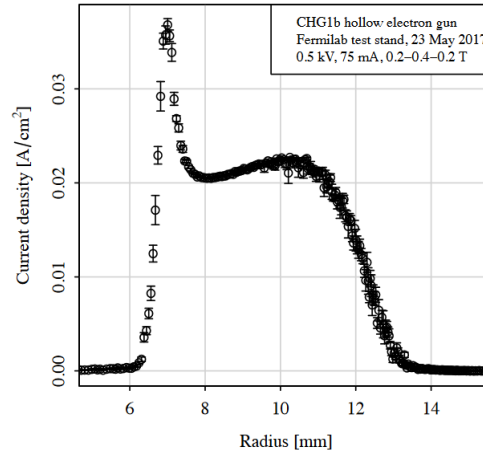
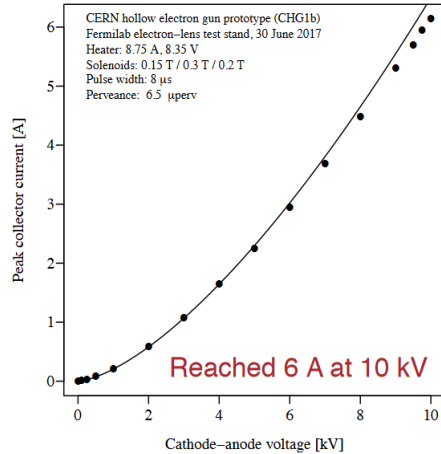
FNAL test stand – model in CST® Particle Studio



FNAL test stand – electron gun



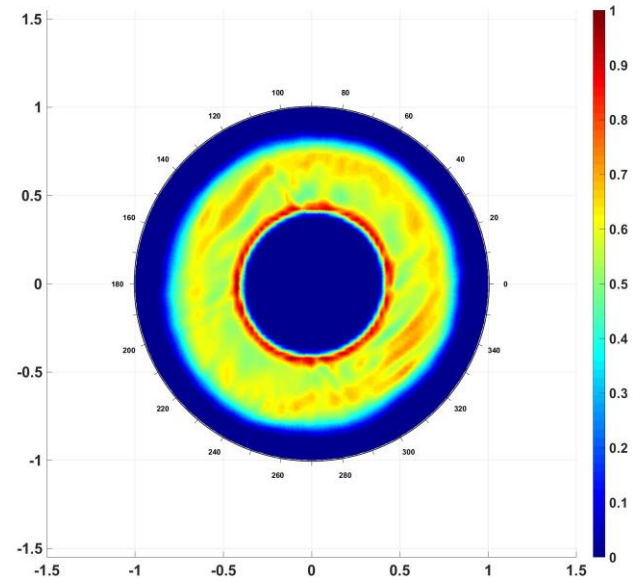
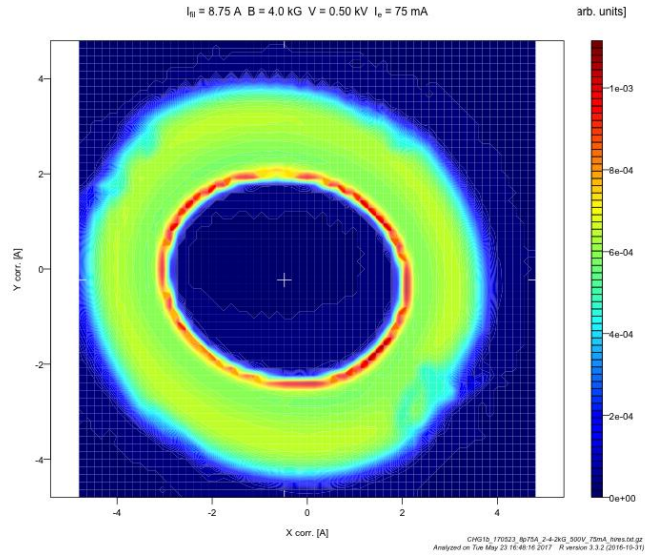
Measured performance of CHG1b 25-mm e-gun



Data file: CHG1b_170523_8p75A_2-4-2kG_500V_75mA_hires.txt.gz

Courtesy of Giulio Stancari, FNAL

Image comparison



Comparison pixel by pixel can not be used

Image comparison – Polar Fourier Transform

$$f(r, \varphi) = \int_0^{\infty} \sum_{m=-\infty}^{\infty} P_{k,m} \Psi_{k,m}(r, \varphi) k dk$$

$\Psi_{k,m}$ - basis function

$P_{k,m}$ - polar Fourier coefficients

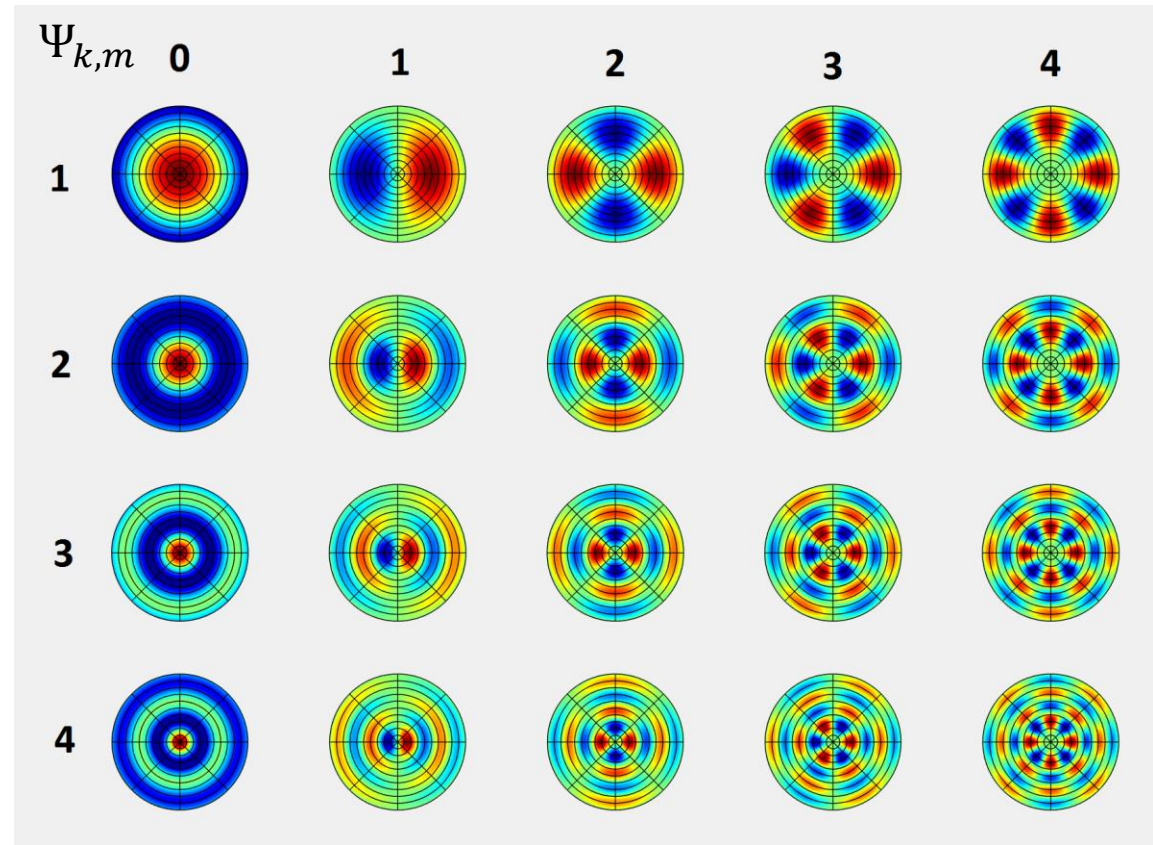
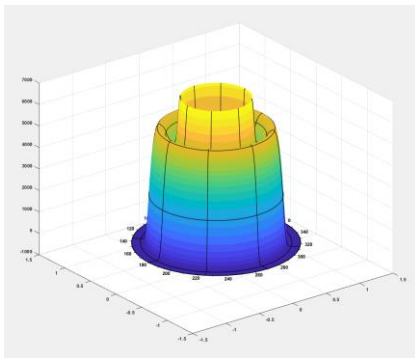
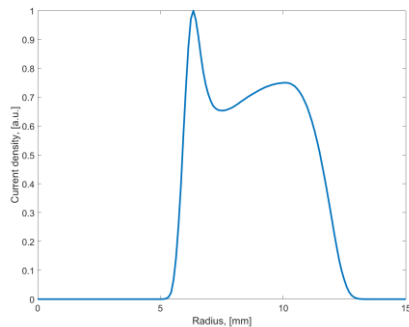


Image comparison – test pulse

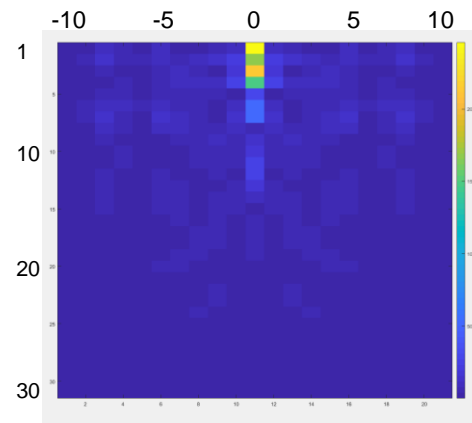
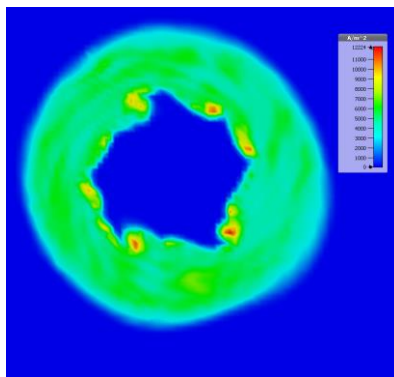
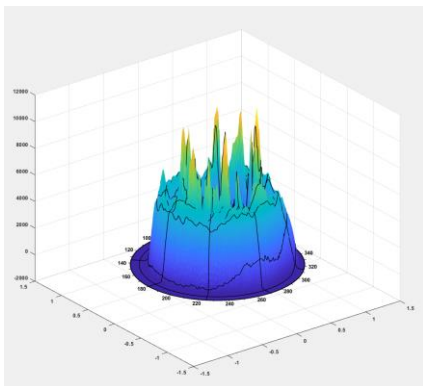
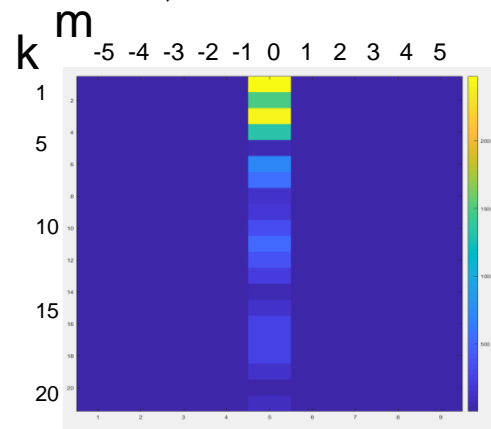
Beam profile in 3D



Beam profile in 2D



$P_{k,m}$ from PFT



Profile evolution (results from FNAL test stand)

Total rotation phase φ of the hollow electron beam

$$\varphi \approx \Omega_D \Delta T \propto \frac{n_{e0} L}{B v_z}$$

$$\Omega_D - \text{diocotron frequency} = \frac{\omega_{pe}^2}{2\omega_{ce}} \propto \frac{n_{e0}}{B}$$

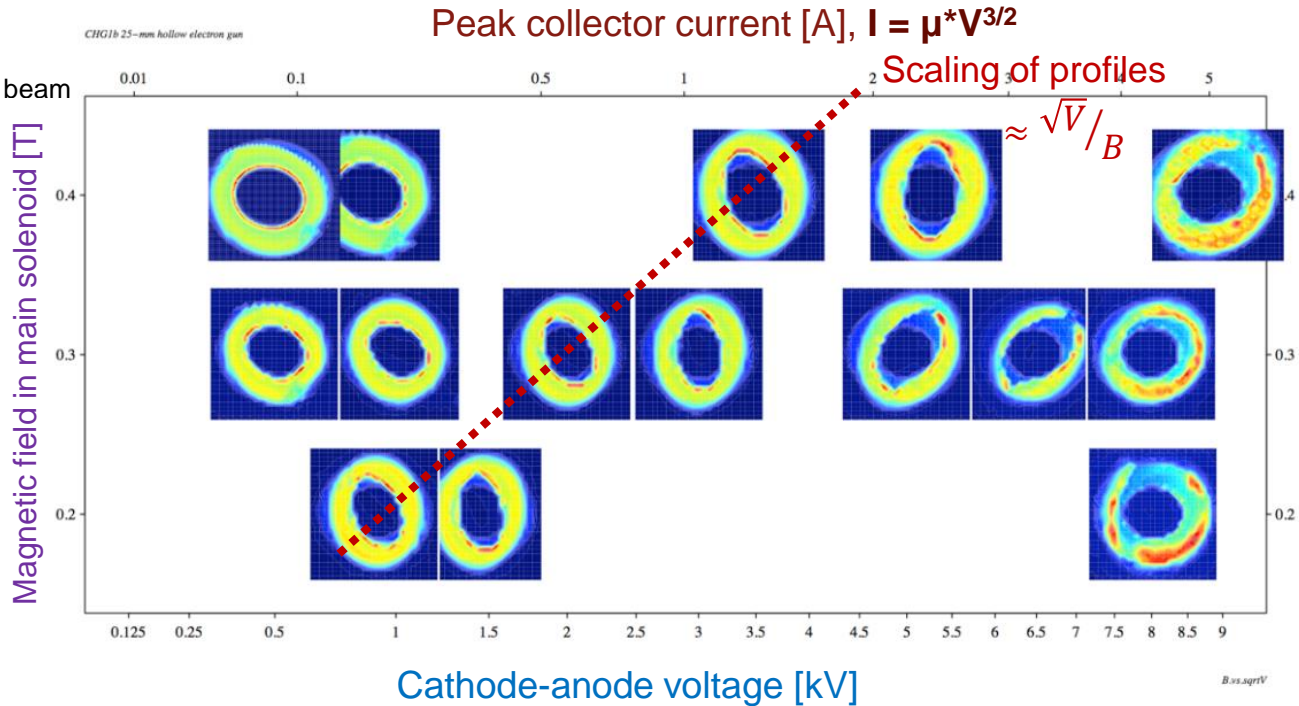
$$\Delta T - \text{transient time} \approx \frac{L}{v_z}$$

$$v_z \approx \sqrt{\frac{2eV}{m_e}} \propto \sqrt{V}$$

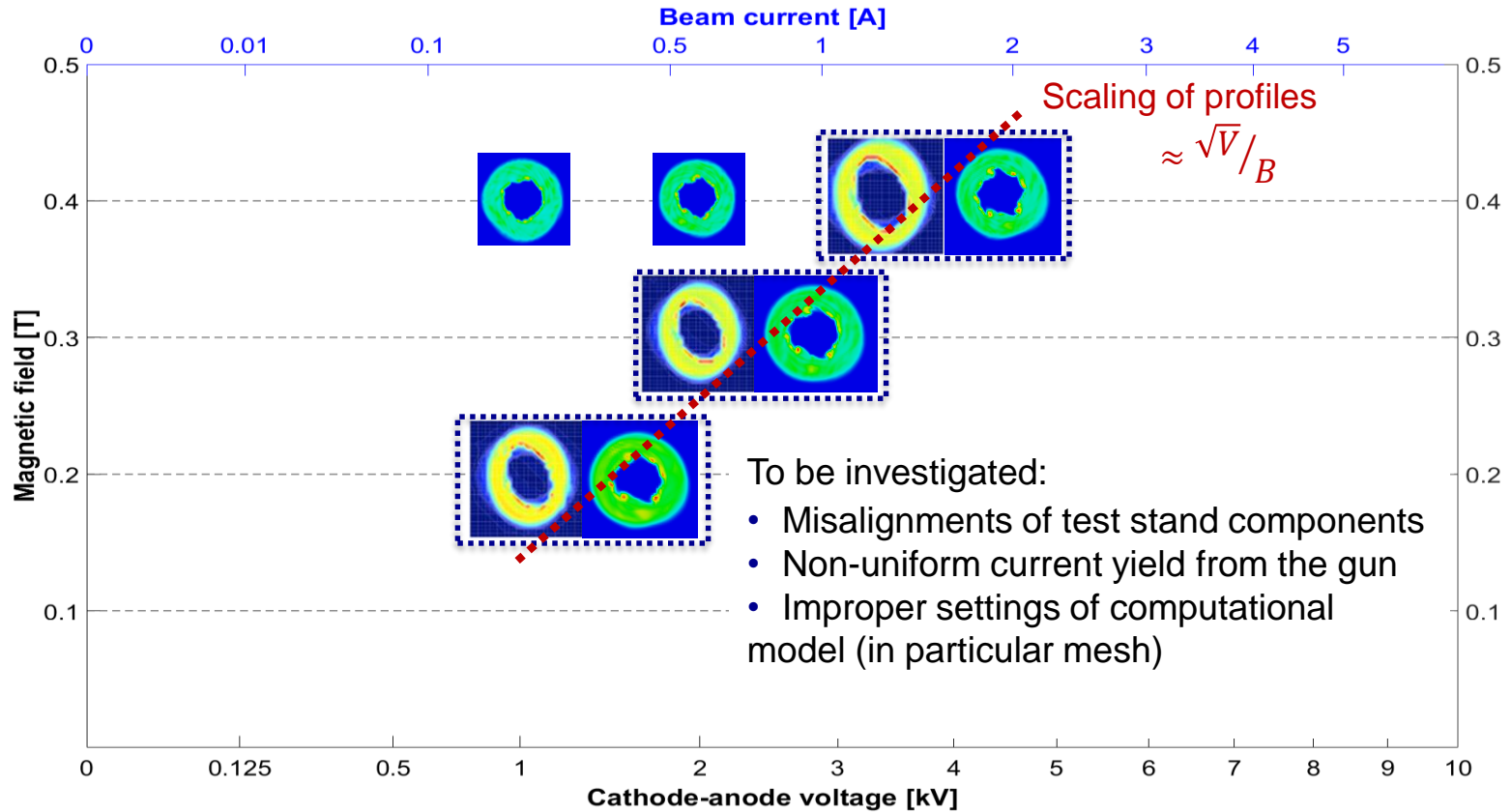
$$J = n_{e0} e v_z \propto V^{3/2}$$

Child-Langmuir law

$$\varphi \approx \text{const} \times \frac{\sqrt{V}}{B} L$$

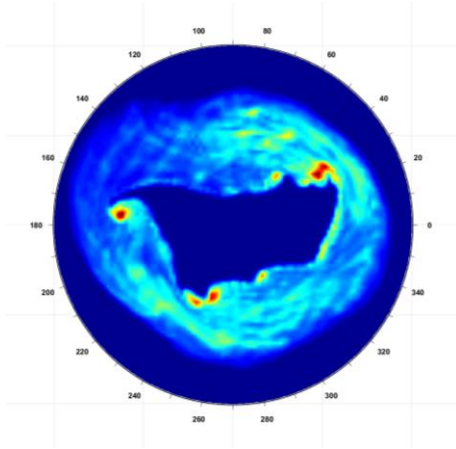


Profile evolution - simulation

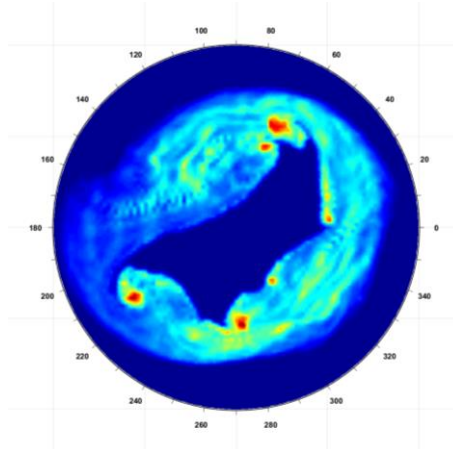


Profiles of the beam with tilted gun

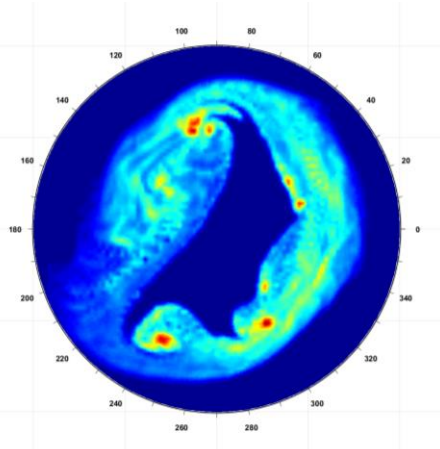
2 kV / 0.4T / 2700 mm



4kV / 0.4T / 2700 mm



6kV / 0.4T / 2700 mm

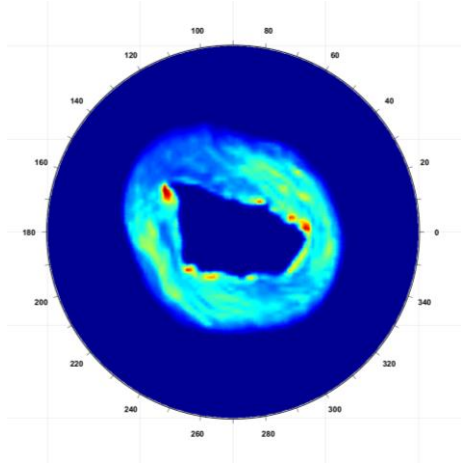


*In simulations gun is tilted by 2° and then aligned by steerers.

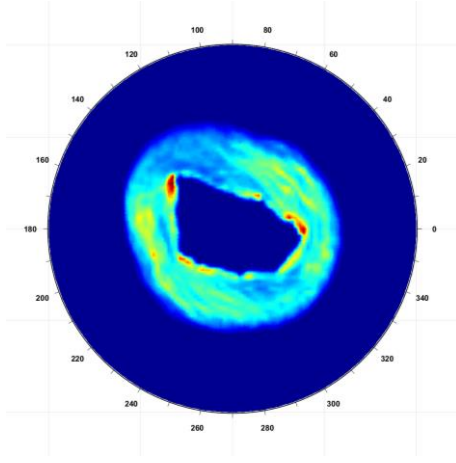
$$\varphi \approx \text{const} \times \frac{\sqrt{V}}{B} L$$

Scaling of profiles vs Length (simulation)

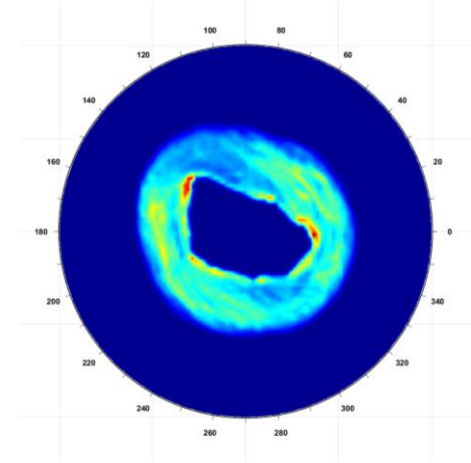
2 kV / 0.4T / 2000 mm



4kV / 0.4T / 1414 mm



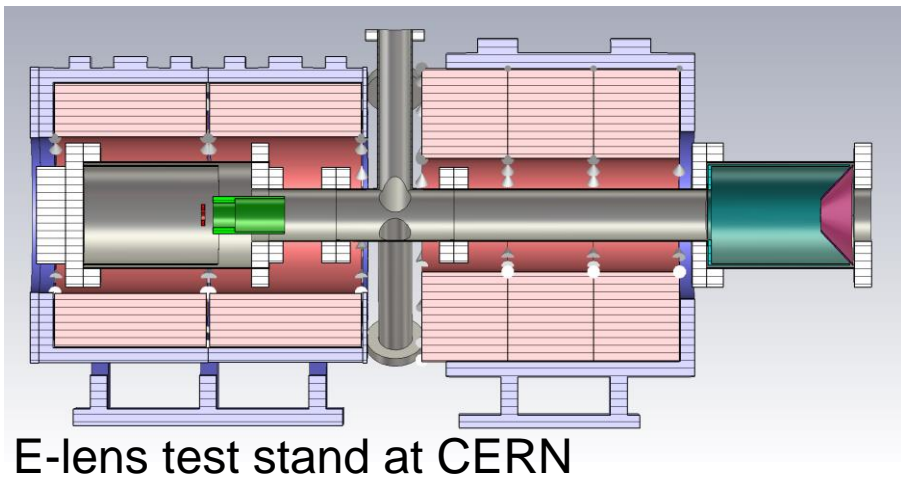
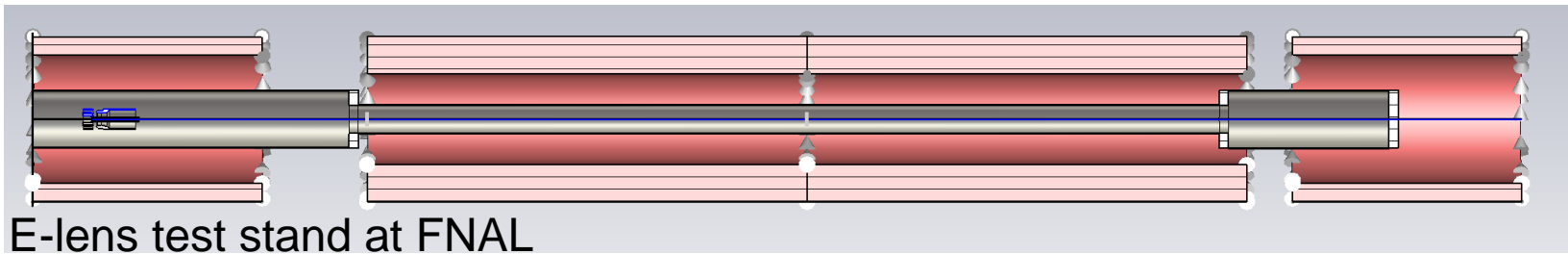
6kV / 0.4T / 1155 mm



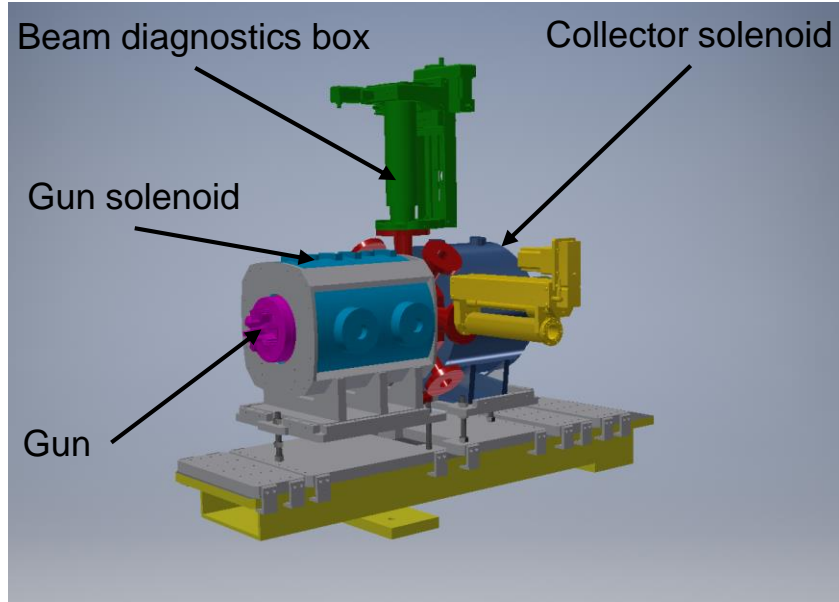
*In simulations gun is tilted by 2° and then aligned by steerers.

$$\varphi \approx \frac{\sqrt{V}}{B} L \quad \frac{\sqrt{2} [kV]}{0.4 [T]} 2000 [mm] \quad \approx \quad \frac{\sqrt{4} [kV]}{0.4 [T]} 1414 [mm] \quad \approx \quad \frac{\sqrt{6} [kV]}{0.4 [T]} 1155 [mm]$$

E-lens test stand at CERN



Electron lens test stand at CERN: stage 1



Purpose of first stage:

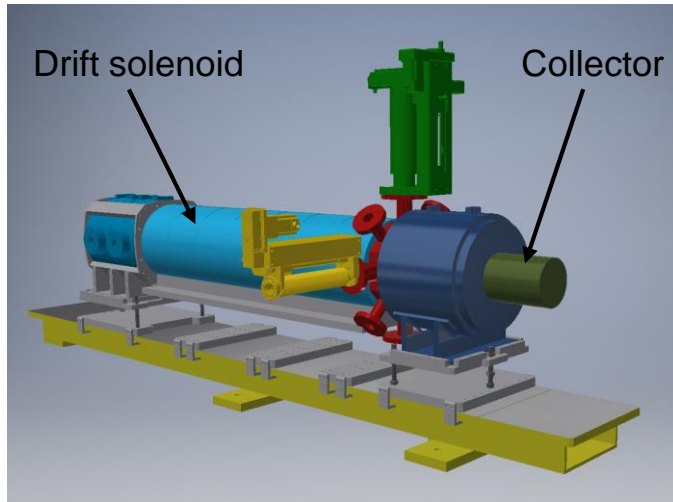
- Preparation:
 - Commissioning hardware (magnets, vacuum, HV system, control, etc.)
 - Safety and technical aspects of operation
 - Commissioning diagnostic procedures (current, profile, position)
- Measurements:
 - Electron gun tests: characterization (profile measurements)
 - Electron gun: anode modular

Covered by HL-LHC

Conclusions

- Measurements at FNAL electron lens test stand were simulated using CST® Particle Studio:
 - Perveance of the gun and initial beam profile are in good agreement
 - Beam profiles from experimental measurements are more distorted comparing to results from simulation
 - Possible reasons of such discrepancies should be investigated:
 - Misalignments of test stand components
 - Non-uniform current yield from the gun
 - Improper settings of computational model (in particular mesh)
- E-lens test bench at CERN will give additional capabilities for gun characterization.
- Comparison of profiles based on Fourier decomposition in polar coordinates was introduced for data analysis.

Test stand: stage 2.

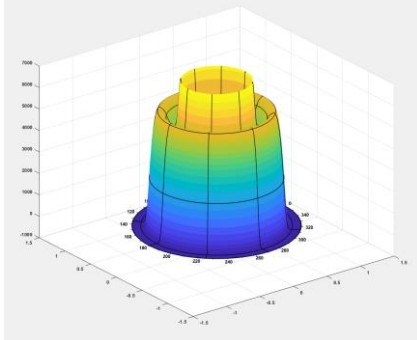
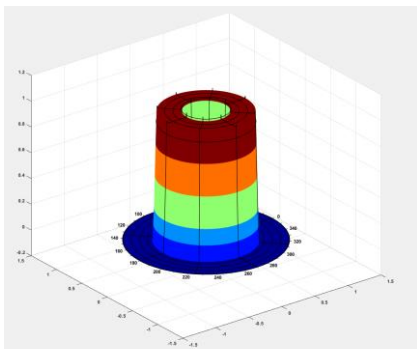


Purpose and measurements of stage 2:

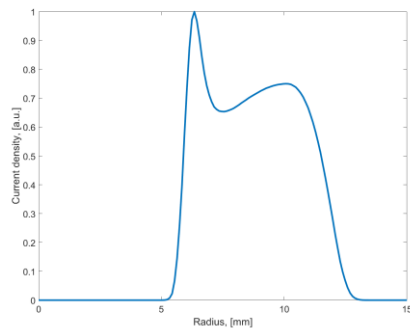
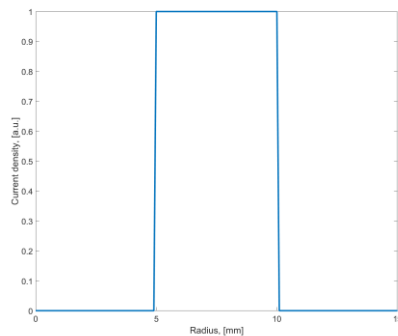
- Allow drift and see beam deformations/rotations/... computer model validation
- Study electron beam dynamics in regime close to virtual cathode
- Study electron beam dynamics with compression
- Test Beam Position Monitor 'shoe-box' or 'strip-line' with very HF modulation
- Test effect of very HF modulation (<10% current) on beam dynamics (microbunching?) for HEL

Image comparison – test pulse

Beam profile in 3D



Beam profile in 2D



$P_{k,m}$ from PFT

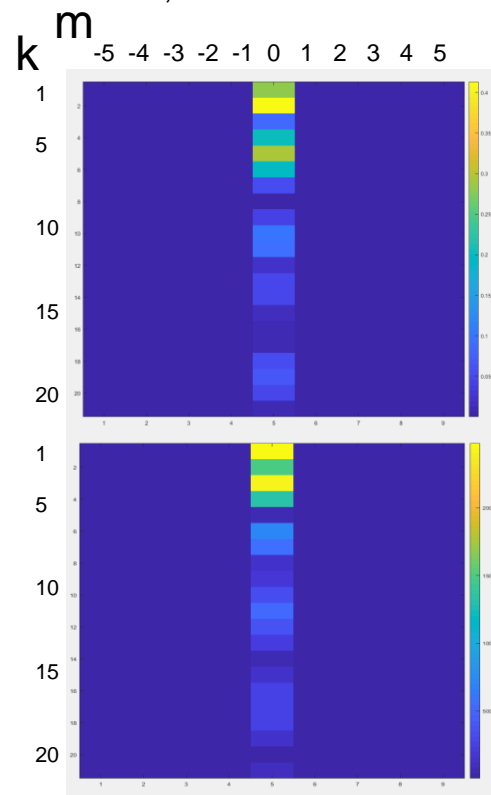
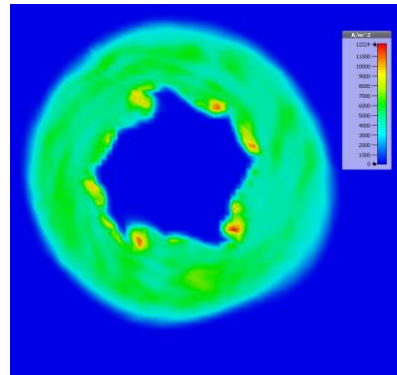
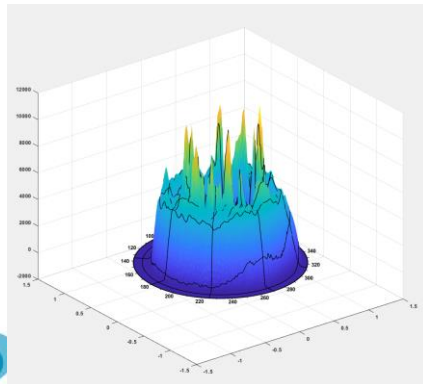
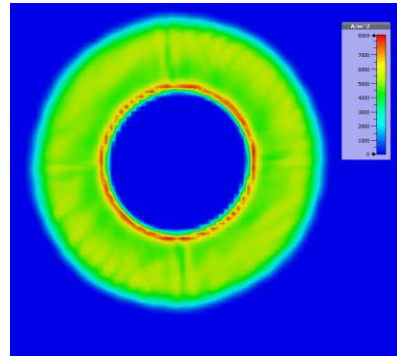
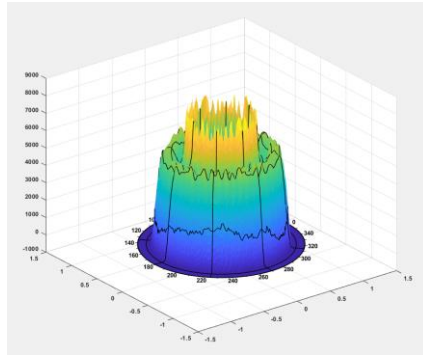


Image comparison – distorted beam



$P_{k,m}$ from PFT

